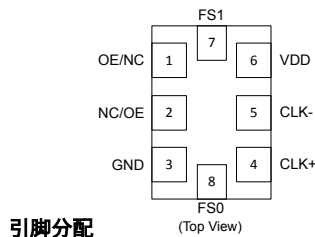


# Ultra Series™ 晶体振荡器系列

## Si562 数据表

### 超低抖动任意四频 XO (90 fs), 0.2 至 3000 MHz

Si562 Ultra Series™ 振荡器系列采用 Silicon Laboratories 先进的第四代 DSPLL® 技术，提供可选双频的超低抖动和低相位噪声时钟。这款设备经过出厂前预编程，可提供频率范围在 0.2 至 3000 MHz 之间的任意可选四频，分辨率小于 <math><1\text{ ppb}</math>，可以在整个工作范围内实现整数和小数频率的超低抖动。Si562 振荡器系列提供出色的可靠性、频率稳定性和抗老化性能。片上电源滤波可以实现行业领先的电源噪声抑制特性，简化了使用开关电源的噪声系统生成低抖动时钟的任务。Si562 振荡器系列采用行业标准 3.2x5 mm 和 5x7 mm 封装，大幅简化供应链，使 Silicon Labs 在收到订单后 1-2 周内即可将定制频率样品送达。不同于传统的 XO，Si562 振荡器系列无需使用不同的晶体实现不同的输出频率，而使用单一晶体和基于 DSPLL IC 的方法提供所需输出频率。这一流程也保证了每个设备的 100% 电气测试。Si562 振荡器系列经工厂配置，可以满足各种各样的用户规格，包括频率、输出格式和 OE 引脚位置/极性。特殊配置在发货时经过出厂前编程，消除了与定制频率振荡器有关的长交付周期。



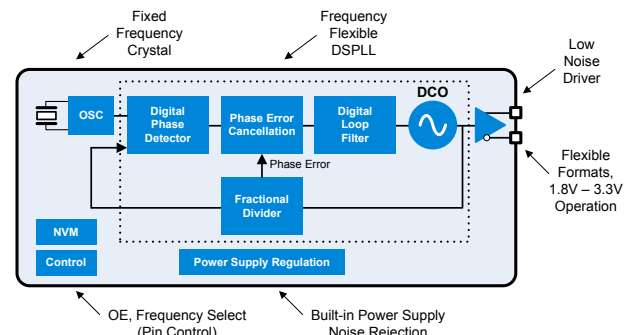
引脚编号	说明
1, 2	订购可选项 OE 表示“输出使能”；NC 表示“无连接”
3	GND 表示“接地”
4	CLK+ 表示“时钟输出”
5	CLK- 表示“互补时钟输出”。CMOS 输出格式下不可用。
6	VDD 表示“电源电压”
7	FS1 表示“频率选择 1”
8	FS0 表示“频率选择 0”

#### 主要特点

- 可以选择 200 kHz 至 3000 MHz 之间的任意可选四频
- 超低抖动：90 fs RMS 典型值（12 kHz - 20 MHz）
- 出色的 PSRR 和电源噪声抗扰度：-80 dBc（典型值）
- 20 ppm 温度稳定性（-40 至 85 °C）
- 相同部件编号可实现 3.3 V、2.5 V 和 1.8 V 的供电电压电源操作
- 提供 LVPECL、LVDS、CML、HCSL、CMOS 和双路 CMOS 输出选项
- 3.2x5、5x7 mm 封装尺寸
- 样品交付周期为 1-2 周

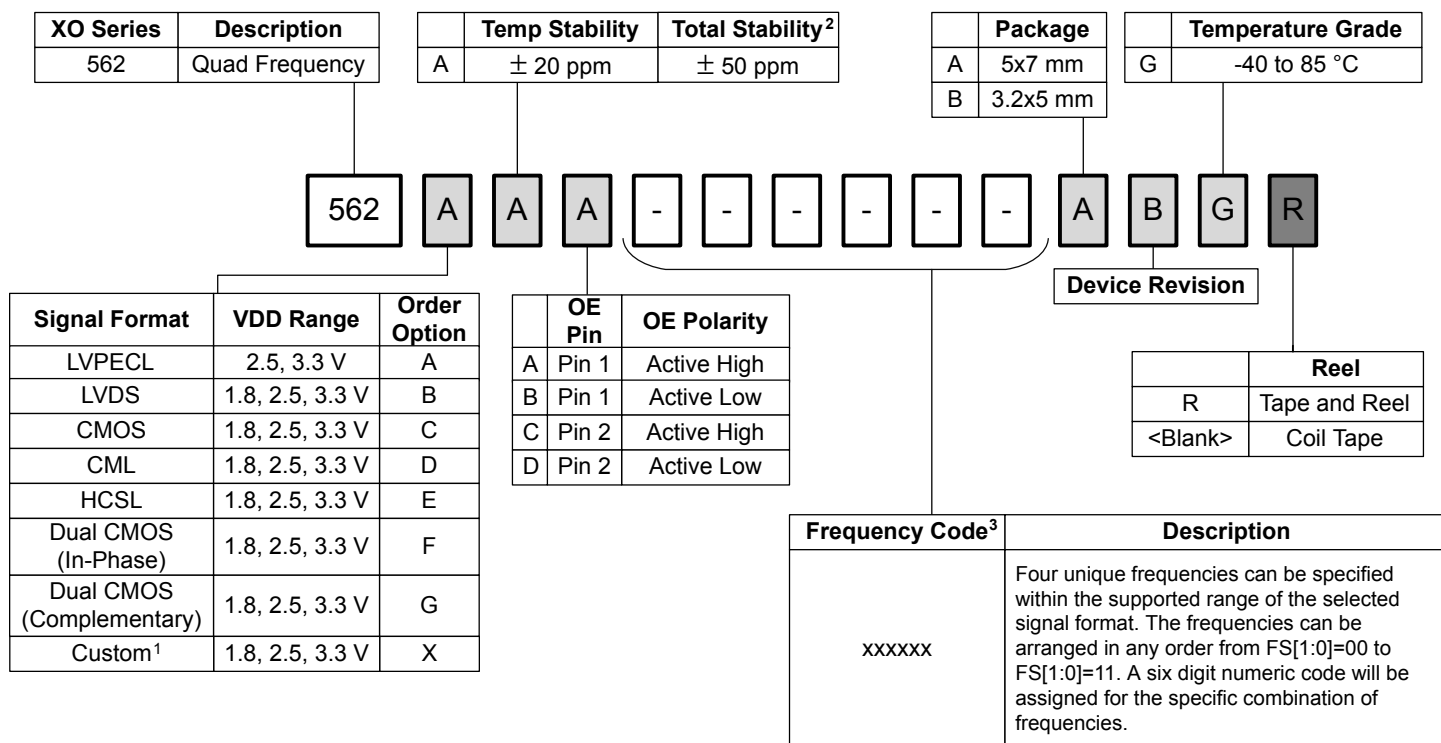
#### 应用

- 100G/200G/400G 相干光学 OTN
- 10G/25G/40G/100G 以太网
- 3G-SDI/12G-SDI/24G-SDI 广播视频
- 服务器、开关、存储、网卡、搜索加速
- 测试和测量
- 时钟数据恢复
- FPGA/ASIC 时钟设计



## 1. Ordering Guide

The Si562 XO supports a variety of options including frequency, output format, and OE pin location/polarity, as shown in the chart below. Specific device configurations are programmed into the part at time of shipment, and samples are available in 1-2 weeks. Silicon Laboratories provides an online part number configuration utility to simplify this process. Refer to [www.silabs.com/oscillators](http://www.silabs.com/oscillators) to access this tool and for further ordering instructions.



### Notes:

- Contact Silicon Labs for non-standard configurations.
- Total stability includes temp stability, initial accuracy, load pulling, VDD variation, and 20 year aging at 70 °C.
- Create custom part numbers at [www.silabs.com/oscillators](http://www.silabs.com/oscillators).

### 1.1 Technical Support

Frequently Asked Questions (FAQ)	<a href="http://www.silabs.com/Si562-FAQ">www.silabs.com/Si562-FAQ</a>
Oscillator Phase Noise Lookup Utility	<a href="http://www.silabs.com/oscillator-phase-noise-lookup">www.silabs.com/oscillator-phase-noise-lookup</a>
Quality and Reliability	<a href="http://www.silabs.com/quality">www.silabs.com/quality</a>
Development Kits	<a href="http://www.silabs.com/oscillator-tools">www.silabs.com/oscillator-tools</a>

## 2. Electrical Specifications

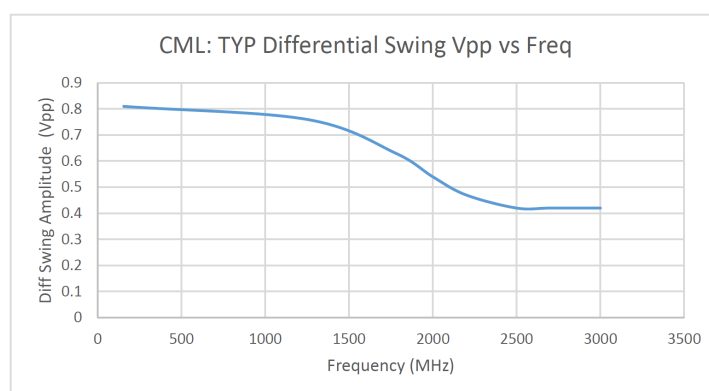
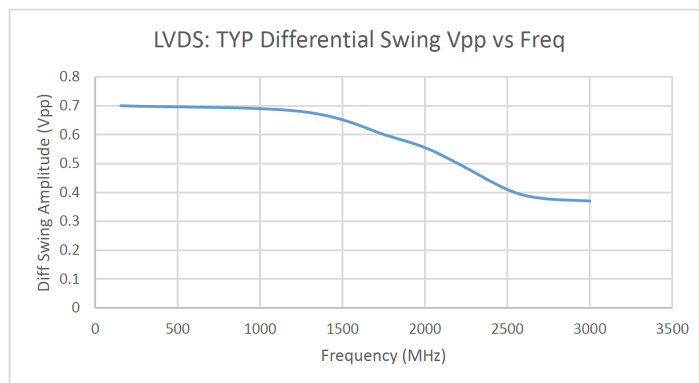
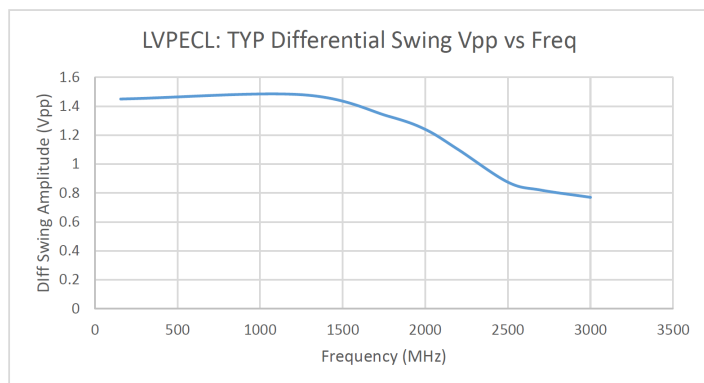
**Table 2.1. Electrical Specifications**
 $V_{DD} = 1.8\text{ V}, 2.5\text{ or }3.3\text{ V} \pm 5\%$ ,  $T_A = -40\text{ to }85\text{ }^\circ\text{C}$ 

Parameter	Symbol	Test Condition/Comment	Min	Typ	Max	Unit
Temperature Range	$T_A$		-40	—	85	$^\circ\text{C}$
Frequency Range	$F_{CLK}$	LVPECL, LVDS, CML	0.2	—	3000	MHz
		HCSL	0.2	—	400	MHz
		CMOS, Dual CMOS	0.2	—	250	MHz
Supply Voltage	$V_{DD}$	3.3 V	3.135	3.3	3.465	V
		2.5 V	2.375	2.5	2.625	V
		1.8 V	1.71	1.8	1.89	V
Supply Current	$I_{DD}$	LVPECL (output enabled)	—	110	160	mA
		LVDS/CML (output enabled)	—	90	157	mA
		HCSL (output enabled)	—	85	130	mA
		CMOS (output enabled)	—	85	135	mA
		Dual CMOS (output enabled)	—	95	145	mA
		Tristate Hi-Z (output disabled)	—	73	—	mA
Temperature Stability		Frequency stability Grade A	-20	—	20	ppm
Total Stability <sup>1</sup>	$F_{STAB}$	Frequency stability Grade A	-50	—	50	ppm
Rise/Fall Time (20% to 80% $V_{PP}$ )	$T_R/T_F$	LVPECL/LVDS/CML	—	—	350	ps
		CMOS / Dual CMOS ( $C_L = 5\text{ pF}$ )	—	0.5	1.5	ns
		HCSL, $F_{CLK} > 50\text{ MHz}$	—	—	550	ps
Duty Cycle	$D_C$	All formats	45	—	55	%
Output Enable (OE) Frequency Select (FS0, FS1) <sup>2</sup>	$V_{IH}$		$0.7 \times V_{DD}$	—	—	V
	$V_{IL}$		—	—	$0.3 \times V_{DD}$	V
	$T_D$	Output Disable Time, $F_{CLK} > 10\text{ MHz}$	—	—	3	$\mu\text{s}$
	$T_E$	Output Enable Time, $F_{CLK} > 10\text{ MHz}$	—	—	20	$\mu\text{s}$
	$T_{FS}$	Settling Time after FS Change	—	—	10	ms
Powerup Time	$t_{OSC}$	Time from $0.9 \times V_{DD}$ until output frequency ( $F_{CLK}$ ) within spec	—	—	10	ms
LVPECL Output Option <sup>3</sup>	$V_{OC}$	Mid-level	$V_{DD} - 1.42$	—	$V_{DD} - 1.25$	V
	$V_O$	Swing (diff, $F_{CLK} \leq 1.5\text{ GHz}$ )	1.1	—	1.9	$V_{PP}$
		Swing (diff, $F_{CLK} > 1.5\text{ GHz}$ ) <sup>6</sup>	0.55	—	1.7	$V_{PP}$

Parameter	Symbol	Test Condition/Comment	Min	Typ	Max	Unit
LVDS Output Option <sup>4</sup>	V <sub>OC</sub>	Mid-level (2.5 V, 3.3 V V <sub>DD</sub> )	1.125	1.20	1.275	V
		Mid-level (1.8 V V <sub>DD</sub> )	0.8	0.9	1.0	V
	V <sub>O</sub>	Swing (diff, F <sub>CLK</sub> ≤ 1.5 GHz)	0.5	0.7	0.9	V <sub>PP</sub>
		Swing (diff, F <sub>CLK</sub> > 1.5 GHz) <sup>6</sup>	0.25	0.5	0.8	V <sub>PP</sub>
HCSL Output Option <sup>5</sup>	V <sub>OH</sub>	Output voltage high	660	800	850	mV
	V <sub>OL</sub>	Output voltage low	-150	0	150	mV
	V <sub>C</sub>	Crossing voltage	250	410	550	mV
CML Output Option (AC-Coupled)	V <sub>O</sub>	Swing (diff, F <sub>CLK</sub> ≤ 1.5 GHz)	0.6	0.8	1.0	V <sub>PP</sub>
		Swing (diff, F <sub>CLK</sub> > 1.5 GHz) <sup>6</sup>	0.3	0.55	0.9	V <sub>PP</sub>
CMOS Output Option	V <sub>OH</sub>	I <sub>OH</sub> = 8/6/4 mA for 3.3/2.5/1.8 V V <sub>DD</sub>	0.85 × V <sub>DD</sub>	—	—	V
	V <sub>OL</sub>	I <sub>OL</sub> = 8/6/4 mA for 3.3/2.5/1.8 V V <sub>DD</sub>	—	—	0.15 × V <sub>DD</sub>	V

**Notes:**

- Total Stability includes temperature stability, initial accuracy, load pulling, V<sub>DD</sub> variation, and aging for 20 yrs at 70 °C.
- OE includes a 50 kΩ pull-up to V<sub>DD</sub> for OE active high, or includes a 50 kΩ pull-down to GND for OE active low. FS0 and FS1 pins each include a 50 kΩ pull-up to V<sub>DD</sub>. NC (No Connect) pins include a 50 kΩ pull-down to GND.
- R<sub>term</sub> = 50 Ω to V<sub>DD</sub> - 2.0 V (see Figure 4.1).
- R<sub>term</sub> = 100 Ω (differential) (see Figure 4.2).
- R<sub>term</sub> = 50 Ω to GND (see Figure 4.2).
- Refer to the figure below for Typical Clock Output Swing Amplitudes vs Frequency.



**Figure 2.1. Typical Clock Output Swing Amplitudes vs. Frequency**

**Table 2.2. Clock Output Phase Jitter and PSRR**

$V_{DD} = 1.8\text{ V}, 2.5\text{ or }3.3\text{ V} \pm 5\%$ ,  $T_A = -40\text{ to }85\text{ }^\circ\text{C}$

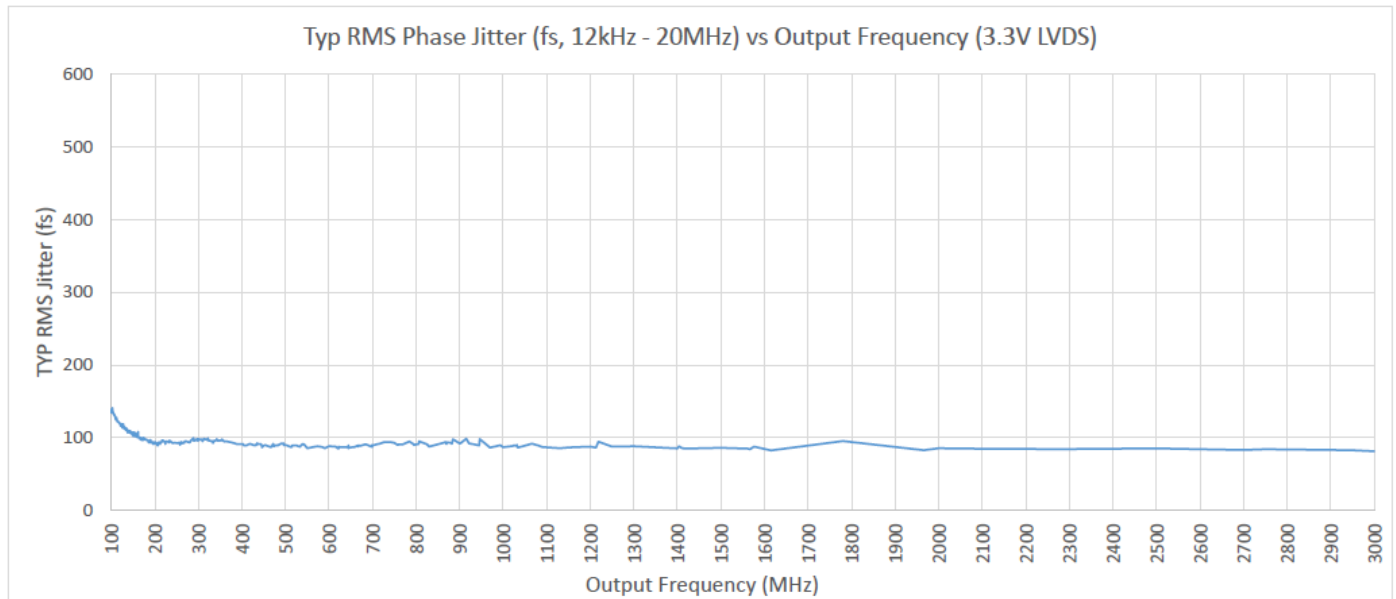
Parameter	Symbol	Test Condition/Comment	Min	Typ	Max	Unit
Phase Jitter (RMS, 12 kHz - 20 MHz) <sup>1</sup> All Differential Formats	$\phi_J$	$F_{CLK} \geq 200\text{ MHz}$	—	90	140	fs
		$100\text{ MHz} \leq F_{CLK} < 200\text{ MHz}$	—	105	160	fs
		LVPECL @ 156.25 MHz	—	95	125	fs
Phase Jitter (RMS, 12 kHz - 20 MHz) <sup>1</sup> CMOS / Dual CMOS Formats	$\phi_J$	$10\text{ MHz} \leq F_{CLK} < 250\text{ MHz}$	—	200	—	fs
Spurs Induced by External Power Supply Noise, 50 mVpp Ripple. LVDS 156.25 MHz Output	PSRR	100 kHz sine wave		-83		dBc
		200 kHz sine wave		-83		
		500 kHz sine wave		-82		
		1 MHz sine wave		-85		

**Note:**

1. Jitter inclusive of any spurs.

**Table 2.3. 3.2 x 5 mm Clock Output Phase Noise (Typical)**

Offset Frequency (f)	156.25 MHz LVDS	200 MHz LVDS	644.53125 MHz LVDS	Unit
100 Hz	-105	-100	-92	dBc/Hz
1 kHz	-129	-126	-116	
10 kHz	-136	-133	-125	
100 kHz	-142	-140	-131	
1 MHz	-150	-148	-138	
10 MHz	-159	-161	-153	
20 MHz	-160	-162	-154	
Offset Frequency (f)	156.25 MHz LVPECL	200 MHz LVPECL	644.53125 MHz LVPECL	Unit
100 Hz	-109	-102	-92	dBc/Hz
1 kHz	-131	-126	-119	
10 kHz	-135	-134	-124	
100 kHz	-143	-141	-130	
1 MHz	-150	-148	-138	
10 MHz	-160	-162	-154	
20 MHz	-161	-163	-155	



**Figure 2.2. Phase Jitter vs. Output Frequency**

Phase jitter measured with Agilent E5052 using a differential-to-single ended converter (balun or buffer). Measurements collected for >700 commonly used frequencies. Phase noise plots for specific frequencies are available using our free, online Oscillator Phase Noise Lookup Tool at [www.silabs.com/oscillators](http://www.silabs.com/oscillators).

Table 2.4. Environmental Compliance and Package Information

Parameter	Test Condition
Mechanical Shock	MIL-STD-883, Method 2002
Mechanical Vibration	MIL-STD-883, Method 2007
Solderability	MIL-STD-883, Method 2003
Gross and Fine Leak	MIL-STD-883, Method 1014
Resistance to Solder Heat	MIL-STD-883, Method 2036
Moisture Sensitivity Level (MSL)	1
Contact Pads	Gold over Nickel

**Note:**

- For additional product information not listed in the data sheet (e.g. RoHS Certifications, MDDS data, qualification data, REACH Declarations, ECCN codes, etc.), refer to our "Corporate Request For Information" portal found here: [www.silabs.com/support/quality/Pages/RoHSInformation.aspx](http://www.silabs.com/support/quality/Pages/RoHSInformation.aspx).

Table 2.5. Thermal Conditions

Package	Parameter	Symbol	Test Condition	Value	Unit
3.2×5 mm 8-pin CLCC	Thermal Resistance Junction to Ambient	$\Theta_{JA}$	Still Air, 85 °C	79.1	°C/W
	Thermal Resistance Junction to Board	$\Theta_{JB}$	Still Air, 85 °C	49.6	°C/W
	Max Junction Temperature	$T_J$	Still Air, 85 °C	125	°C
5×7 mm 8-pin CLCC	Thermal Resistance Junction to Ambient	$\Theta_{JA}$	Still Air, 85 °C	67.1	°C/W
	Thermal Resistance Junction to Board	$\Theta_{JB}$	Still Air, 85 °C	51.7	°C/W
	Max Junction Temperature	$T_J$	Still Air, 85 °C	125	°C

Table 2.6. Absolute Maximum Ratings<sup>1</sup>

Parameter	Symbol	Rating	Unit
Maximum Operating Temp.	$T_{AMAX}$	95	°C
Storage Temperature	$T_S$	-55 to 125	°C
Supply Voltage	$V_{DD}$	-0.5 to 3.8	°C
Input Voltage	$V_{IN}$	-0.5 to $V_{DD} + 0.3$	V
ESD HBM (JESD22-A114)	HBM	2.0	kV
Solder Temperature <sup>2</sup>	$T_{PEAK}$	260	°C
Solder Time at $T_{PEAK}$ <sup>2</sup>	$T_P$	20–40	sec

**Notes:**

- Stresses beyond those listed in this table may cause permanent damage to the device. Functional operation specification compliance is not implied at these conditions. Exposure to maximum rating conditions for extended periods may affect device reliability.
- The device is compliant with JEDEC J-STD-020.



### 3. Dual CMOS Buffer

Dual CMOS output format ordering options support either complementary or in-phase signals for two identical frequency outputs. This feature enables replacement of multiple XOs with a single Si562 device.



Figure 3.1. Integrated 1:2 CMOS Buffer Supports Complementary or In-Phase Outputs

## 4. Recommended Output Terminations

The output drivers support both AC-coupled and DC-coupled terminations as shown in figures below.

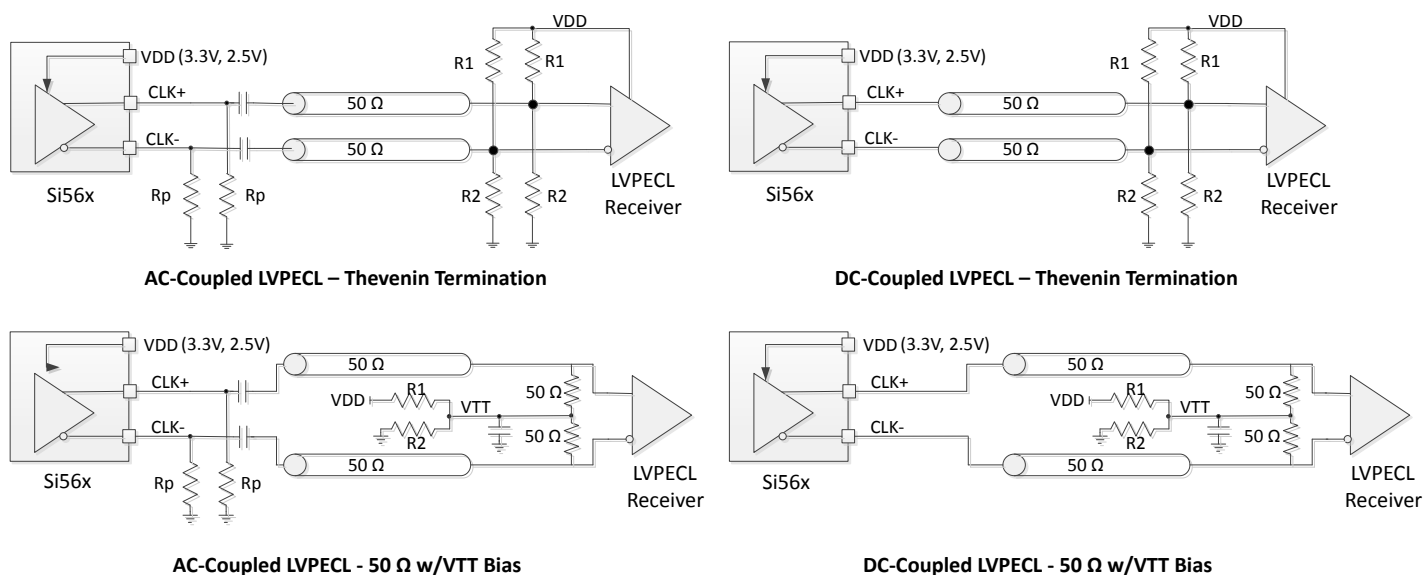


Figure 4.1. LVPECL Output Terminations

AC-Coupled LVPECL Termination Resistor Values				DC-Coupled LVPECL Termination Resistor Values		
VDD	R1	R2	Rp	VDD	R1	R2
3.3 V	127 Ω	82.5 Ω	130 Ω	3.3 V	127 Ω	82.5 Ω
2.5 V	250 Ω	62.5 Ω	90 Ω	2.5 V	250 Ω	62.5 Ω

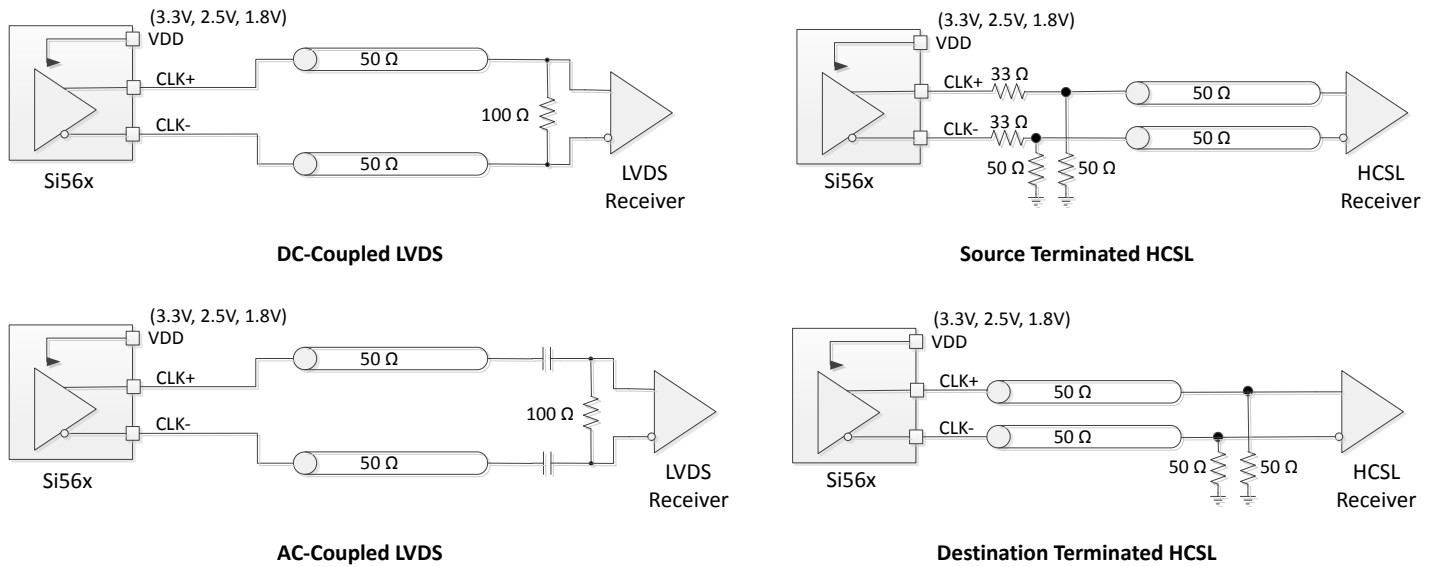


Figure 4.2. LVDS and HCSL Output Terminations

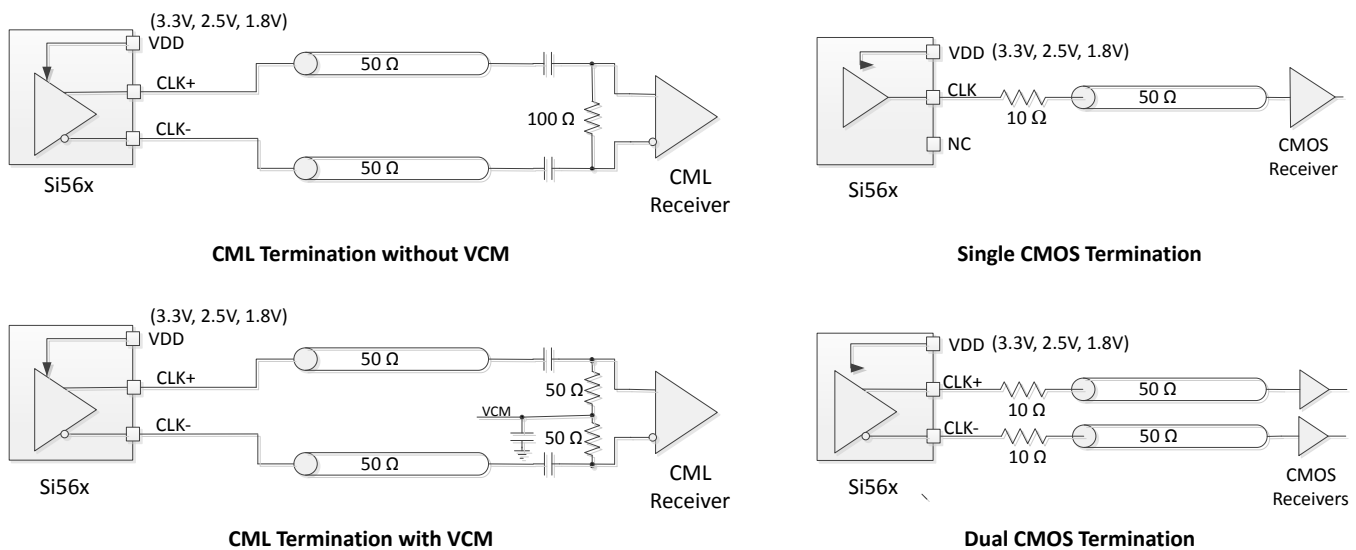


Figure 4.3. CML and CMOS Output Terminations

## 5. Package Outline

### 5.1 Package Outline (5x7 mm)

The figure below illustrates the package details for the 5x7 mm Si562. The table below lists the values for the dimensions shown in the illustration.

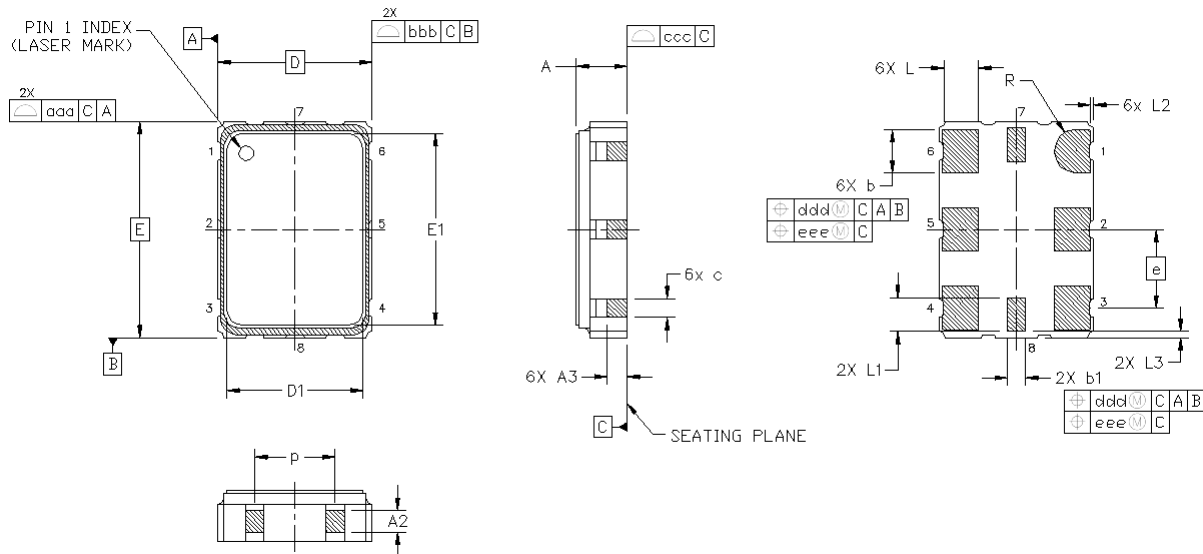


Figure 5.1. Si562 (5x7 mm) Outline Diagram

Table 5.1. Package Diagram Dimensions (mm)

Dimension	Min	Nom	Max	Dimension	Min	Nom	Max
A	1.07	1.18	1.33	E1	6.10	6.20	6.30
A2	0.40	0.50	0.60	L	1.07	1.17	1.27
A3	0.45	0.55	0.65	L1	1.00	1.10	1.20
b	1.30	1.40	1.50	p	1.70	--	1.90
b1	0.50	0.60	0.70	R	0.70 REF		
c	0.50	0.60	0.70	aaa	0.15		
D	5.00 BSC			bbb	0.15		
D1	4.30	4.40	4.50	ccc	0.08		
e	2.54 BSC			ddd	0.10		
E	7.00 BSC			eee	0.05		

**Notes:**

1. All dimensions shown are in millimeters (mm) unless otherwise noted.
2. Dimensioning and Tolerancing per ANSI Y14.5M-1994.

## 5.2 Package Outline (3.2x5 mm)

The figure below illustrates the package details for the 5x3.2 mm Si562. The table below lists the values for the dimensions shown in the illustration.



Figure 5.2. Si562 (3.2x5 mm) Outline Diagram

Table 5.2. Package Diagram Dimensions (mm)

Dimension	MIN	NOM	MAX	Dimension	MIN	NOM	MAX
A	1.02	1.17	1.33	E1	2.85 BSC		
A2	0.50	0.55	0.60	L	0.8	0.9	1.0
A3	0.45	0.50	0.55	L1	0.45	0.55	0.65
b	0.54	0.64	0.74	L2	0.05	0.10	0.15
b1	0.54	0.64	0.75	L3	0.15	0.20	0.25
D	5.00 BSC			aaa	0.15		
D1	4.65 BSC			bbb	0.15		
e	1.27 BSC			ccc	0.08		
e1	1.625 TYP			ddd	0.10		
E	3.20 BSC			eee	0.05		

### Notes:

1. All dimensions shown are in millimeters (mm) unless otherwise noted.
2. Dimensioning and Tolerancing per ANSI Y14.5M-1994.

## 6. PCB Land Pattern

### 6.1 PCB Land Pattern (5x7 mm)

The figure below illustrates the 5x7 mm PCB land pattern for the Si562. The table below lists the values for the dimensions shown in the illustration.



Figure 6.1. Si562 (5x7 mm) PCB Land Pattern

Table 6.1. PCB Land Pattern Dimensions (mm)

Dimension	(mm)	Dimension	(mm)
C1	4.20	Y1	1.95
C2	6.05	X2	1.80
E	2.54	Y2	0.75
X1	1.55		

#### Notes:

##### General

1. All dimensions shown are in millimeters (mm) unless otherwise noted.
2. Dimensioning and Tolerancing is per the ANSI Y14.5M-1994 specification.
3. This Land Pattern Design is based on the IPC-7351 guidelines.
4. All dimensions shown are at Maximum Material Condition (MMC). Least Material Condition (LMC) is calculated based on a Fabrication Allowance of 0.05 mm.

##### Solder Mask Design

1. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60  $\mu\text{m}$  minimum, all the way around the pad.

##### Stencil Design

1. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
2. The stencil thickness should be 0.125 mm (5 mils).
3. The ratio of stencil aperture to land pad size should be 1:1.

##### Card Assembly

1. A No-Clean, Type-3 solder paste is recommended.
2. The recommended card reflow profile is per the JEDEC/IPC J-STD-020D specification for Small Body Components.

## 6.2 PCB Land Pattern (3.2x5 mm)

The figure below illustrates the 3.2x5.0 mm PCB land pattern for the Si562. The table below lists the values for the dimensions shown in the illustration.



Figure 6.2. Si562 (3.2x5 mm) PCB Land Pattern

Table 6.2. PCB Land Pattern Dimensions (mm)

Dimension	(mm)	Dimension	(mm)
C1	2.70	X2	0.90
E	1.27	Y1	1.60
E1	4.30	Y2	0.70
X1	0.74		

### Notes:

#### General

1. All dimensions shown are in millimeters (mm) unless otherwise noted.
2. Dimensioning and Tolerancing is per the ANSI Y14.5M-1994 specification.
3. This Land Pattern Design is based on the IPC-7351 guidelines.
4. All dimensions shown are at Maximum Material Condition (MMC). Least Material Condition (LMC) is calculated based on a Fabrication Allowance of 0.05 mm.

#### Solder Mask Design

1. All metal pads are to be non-solder mask defined (NSMD). Clearance between the solder mask and the metal pad is to be 60  $\mu$ m minimum, all the way around the pad.

#### Stencil Design

1. A stainless steel, laser-cut and electro-polished stencil with trapezoidal walls should be used to assure good solder paste release.
2. The stencil thickness should be 0.125 mm (5 mils).
3. The ratio of stencil aperture to land pad size should be 1:1.

#### Card Assembly

1. A No-Clean, Type-3 solder paste is recommended.
2. The recommended card reflow profile is per the JEDEC/IPC J-STD-020C specification for Small Body Components.

## 7. Top Marking

The figure below illustrates the mark specification for the Si562. The table below lists the line information.

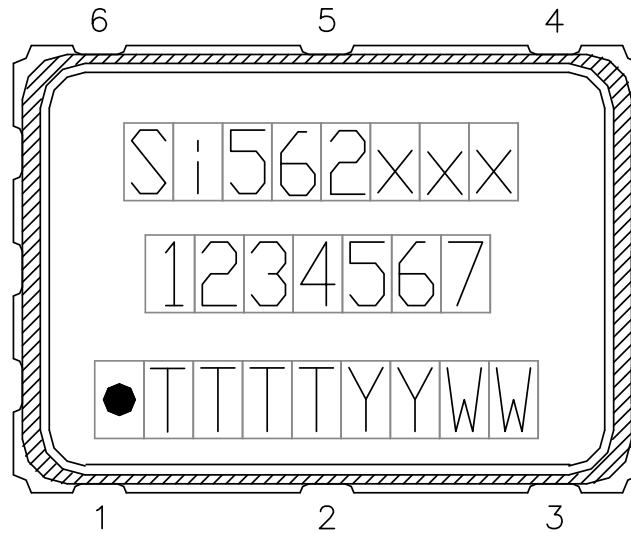


Figure 7.1. Mark Specification

Table 7.1. Si562 Top Mark Description

Line	Position	Description
1	1–8	"Si562", xxx = Ordering Option 1, Option 2, Option 3 (e.g. Si562AAA)
2	1–6	Frequency Code (6-digit custom code as described in the Ordering Guide)
3	<b>Trace Code</b>	
	Position 1	Pin 1 orientation mark (dot)
	Position 2	Product Revision (B)
	Position 3–5	Tiny Trace Code (3 alphanumeric characters per assembly release instructions)
	Position 6–7	Year (last two digits of the year), to be assigned by assembly site (ex: 2017 = 17)
	Position 8–9	Calendar Work Week number (1–53), to be assigned by assembly site



## 8. Revision History

### Revision 1.0

June, 2018

- Initial release.



## ClockBuilder Pro

One-click access to Timing tools, documentation, software, source code libraries & more. Available for Windows and iOS (CBGo only).

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